

UC-8100 Series Component Compatibility Guide

A list of peripheral components suitable for use with the UC-8100 series of computers

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1. Introduction

This document lists hardware components that are proven to provide the performance listed in the specification when used with the Moxa UC-8100 series of embedded computers, or computers that share basic design features with the UC-8100 series. Moxa computers come with multiple peripheral options and are engineered to work with components having different hardware specifications. This flexibility could sometimes lead to compatibility issues. When used with the UC-8100 series of embedded computers, peripherals from one manufacturer may not work as well as the ones made by another manufacturer. Moxa provides this list of UC-8100 series-compatible components, so that users can be certain of a reliable performance from the UC-8100 series, when it is used with the components listed in this document.

2. Testing Methods

To validate that a component meets the Moxa standards for quality and performance, the following five key compatibility tests are run:

- Ambient temperature burn-in
- Low temperature hard start
- Heat/humidity burn-in
- Cyclic high-low temperature burn-in
- Vibration test

Ambient Temperature Burn-In

The component is mounted on to an UC-8100 computer and put through a series of stress tests at an ambient temperature of around 25°C, for a specified period of time. The duration of the test is determined based on the class of peripherals being tested.

Low Temperature Hard Start

The component is mounted on to an unpowered UC-8100 computer and then the system is booted up at an extremely low temperature. The designated low temperature value depends on the computer model being tested.

Heat/Humidity Burn-In

The component is mounted on to an UC-8100 computer, placed in a temperature- and humidity-controlled enclosure, and then put through the burn-in test for a specified period of time. The temperature, humidity, and time targets vary depending on the specification of the computer model used in the test.

Cyclic High-Low Temperature Burn-In

The component is mounted on to an UC-8100 computer, placed in a temperature controlled enclosure, and then put through the burn-in test wherein the temperature is cyclically varied from very high to very low and back again, over a specified period of time. The target temperature range and the duration of the test can vary depending on the specification of the computer model used in the test.

Vibration Test

The component is mounted on to an UC-8100 computer that is bound inside an electromagnetic vibrator, and then put through random vibration tests along three orthogonal axes: longitudinal, transverse, and vertical. The vibration tests are compliant with the EN50155/IEC61373 vibration standards.

3. Storage Endurance

Storage media, such as SSDs, CF cards, SD cards, Disk on Module, and CFast, are composed of different electrical components. The main electrical components in these storage media, the NAND-flash memory and NAND-flash controller, impact the storage endurance and lifespan of the storage media.

NAND-Flash Memory Endurance

NAND-flash memories have a limit on the number of times they can be programmed and erased (P/E). The P/E cycle as well as the erase count of a NAND-flash memory can be used to determine this limit. For example, an SLC (single-level cell) flash memory has a 60,000 P/E cycle, an MLC (multi-level cell) flash memory has a 3,000 P/E cycle, and TLC NAND flash memories have P/E cycle values up to 1,000. Each flash memory type has a different endurance level, which is why the storage lifespan is based on the flash memory type. Storage that uses SLC type flash memory could have the best endurance level compared with the MLC type storage. SLC storage usually comes with a 5-year OEM warranty (the actual warranty period depends on the original manufacturer). MLC storage only comes with a 1- to 3-year warranty. The major differences between SLC and MLC are: (a) The SLC NAND flash has a lifespan that is around 20 times that of an MLC, and (b) The price can differ by a factor of 4 to 5. The SLC type of storage is recommended for systems that are expected to have high reliability, and for applications that need to frequently write data to a storage medium.

Terabytes Written (TBW)

TBW is the unit used to evaluate SSD endurance. In actual applications, storage is used for routine operations and data access. Therefore the physical P/E cycle is not appropriate for describing the total rewritable data capacity. The management efficiency of the storage controller also affects the total rewritable data capacity result. For these reasons, Joint Electron Device Engineering Council (JEDEC) has defined a standard for SSD endurance evaluation called JESD218, which uses TBW to measure the endurance of the storage memory. By referring to this TBW value, users can easily estimate the storage specification and select a suitable storage for real-life use cases. For example, when routine operations need a maximum of 20 GB and the expected storage lifespan is 3 years, the total rewritable data demand would be 21.9 TBW (20 GB x 365 x 3). In this case, a storage that has more than 21.9 TBW will meet the requirement. We recommend selecting a storage media with a TBW that is greater than the calculated value.

4. Declaration for Liability Exclusion

The specifications, warranty terms, and liability of items listed in this guide are the sole responsibility of the original manufacturers. Moxa does not take any responsibility in this regard. Please visit the manufacturers' official websites for up-to-date product information before purchasing the components.

5. Compatible Components

Peripheral components that have been tested and found suitable for use with the UC-8100 series of computers are listed in this section. The following table lists the Test Codes and their descriptions:

Test Code	Description
A	The component has passed the ambient temperature verification test
B	The component has passed the low temperature verification test
C	The component has passed the heat/humidity verification test
D	The component has passed the cyclic high-low temperature verification test
E	The component has not been tested, but is similar to another component that has been tested in terms of its material and design.
F	The component has passed the vibration verification test

SD										
Vendor	Storage Size	Moxa's PN	Vendor's PN	Flash Memory Brand	Flash Memory Spec	Controller	Firmware	Warranty	Warranty Exclusion	Test Codes
ADATA	1 GB	N/A	ASDH32GUILC10-R	N/A	N/A	N/A	N/A	lifetime	N/A	A
Apacer	1 GB	1352000012020	AP-ISD01GIS2B-3T	N/A	SLC	N/A	N/A	3 years	Endurance > 60,000	B, C, D
Apacer	4 GB	N/A	AP-ISD04GCS4A-2CM	Micron	MLC	Phison	N/A	2 years	Endurance > 3,000	E
Apacer	8 GB	N/A	AP8GSDHC10U1	Toshiba	MLC	Phison	N/A	2 years	Endurance > 3,000	E
Apacer	8 GB	N/A	AP-ISD08GCS4A-2CM	Micron	MLC	Phison	N/A	2 years	Endurance > 3,000	E
Apacer	16 GB	N/A	AP16GSDHC10U1	Toshiba	MLC	Phison	N/A	2 years	Endurance > 3,000	E
Apacer	16 GB	N/A	AP16GSDHC10U2	Toshiba	MLC	Phison	N/A	2 years	Endurance > 3,000	E
Apacer	16 GB	N/A	AP-ISD16GCS4A-2CM	Micron	MLC	Phison	N/A	2 years	Endurance > 3,000	E
Apacer	32 GB	N/A	AP32GSDHC10U1-R	Toshiba	MLC	Phison	N/A	2 years	Endurance > 3,000	A
Apacer	32 GB	N/A	AP32GSDHC10U2-R	Toshiba	MLC	Phison	N/A	2 years	Endurance > 3,000	A
Apacer	32 GB	N/A	AP-ISD32GCD4A-2CM	Micron	MLC	Phison	N/A	2 years	Endurance > 3,000	A
InnoDisk	1 GB	1352000012010	DS2A-01GI81W1B	Toshiba	SLC	N/A	N/A	5 years	Endurance > 60,000	B, C, D
InnoDisk	4 GB	1352000042013	DESDC-04GY81RW2SC	Toshiba	MLC	N/A	N/A	2 years	Endurance > 3,000	B, C, D
Memoright	2 GB	N/A	MRSDE1A002GB0S1100	Samsung	SLC	N/A	N/A	5 years	N/A	B, C, D
Silicon Power	1 GB	N/A	SP001GBSDI000W201T	Toshiba	SLC	ITE	N/A	3 years	N/A	A
Transcend	32 GB	N/A	TS32GSDHC10U1	N/A	MLC	N/A	N/A	2 years	N/A	A
Transcend	32 GB	N/A	TS32GSDU1	N/A	MLC	N/A	N/A	2 years	N/A	A

Micro SD										
Vendor	Storage Size	Moxa's PN	Vendor's PN	Flash Memory Brand	Flash Memory Spec	Controller	Firmware	Warranty	Warranty Exclusion	Test Codes
Apacer	2 GB	1352000022012	AP-MSD02GIDI-T	N/A	SLC	N/A	N/A	3 years	Endurance > 60,000	B, C, D
Apacer	8 GB	N/A	AP8GMCSH10U1-R	Toshiba	MLC	Phison	N/A	2 years	Endurance > 3,000	E
Apacer	16 GB	N/A	AP-MSD16GCH4P-1TM	Toshiba	MLC	Phison	N/A	2 years	Endurance > 3,000	E
Apacer	16 GB	N/A	AP16GMCSH10U1-R	Toshiba	MLC	Phison	N/A	2 years	Endurance > 3,000	E
Apacer	32 GB	N/A	AP-MSD32GCH4P-1TM	Toshiba	MLC	Phison	N/A	2 years	Endurance > 3,000	A
Apacer	32 GB	N/A	AP32GMCSH10U1-R	Toshiba	MLC	Phison	N/A	2 years	Endurance > 3,000	A
InnoDisk	2 GB	1352000022011	DS2M-02GI81AW1ST	Micron	SLC	N/A	N/A	5 years	Endurance > 60,000	B, C, D
InnoDisk	4 GB	1352000042010	D2SM-04GI81AW1ST	Micron	SLC	N/A	N/A	5 years	Endurance > 60,000	B, C
InnoDisk	8 GB	1352000082010	D2SM-08GI81AW1ST	Micron	SLC	N/A	N/A	5 years	Endurance > 60,000	B, C
Silicon Power	4 GB	N/A	SP004GBSTH010V10	N/A	SLC	N/A	N/A	3 years	N/A	E
Silicon Power	8 GB	N/A	SP008GBSTH010V10	N/A	SLC	N/A	N/A	3 years	N/A	A
Transcend	8 GB	N/A	TS8GUSDCU1	N/A	MLC	N/A	N/A	2 years	N/A	E
Transcend	16 GB	N/A	TS16GUSDCU1	N/A	MLC	N/A	N/A	2 years	N/A	E
Transcend	32 GB	N/A	TS32GUSDCU1	N/A	MLC	N/A	N/A	2 years	N/A	A